# µRWELL simulation + FEE upgrade R.Farinelli

## Status

 $\mu RWELL$  simulation done

TIGER simulation done

## White noise implementation

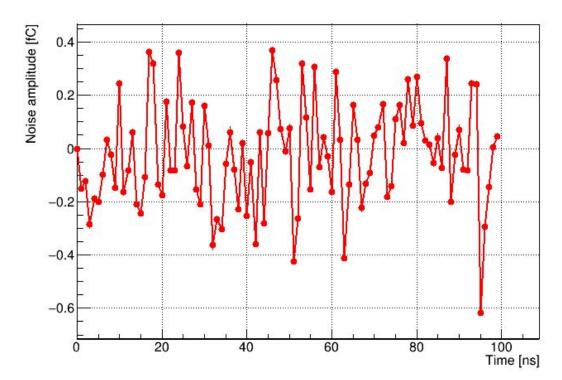
```
const int max_freq = 1e6;
float white_noise(int itime){
  float output=0;
  for(int ifreq=1;ifreq<max_freq;ifreq*=10){
     output+=r->Gaus()*max_amplitude*sin(itime*ifreq);
  }
  return output;
}
```

itime = 1 ns bin

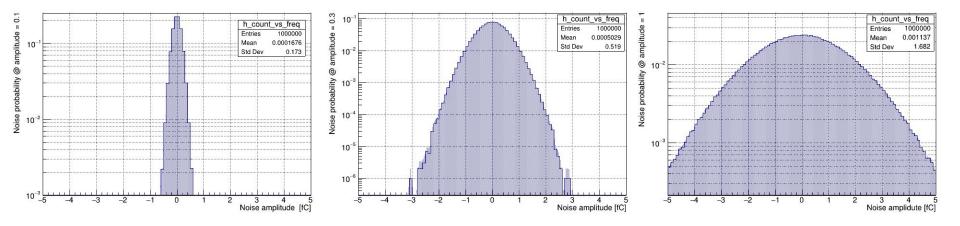
For each frequency [1,10,100,1000,10000] a sinusoidal function with the same amplitude is considered.

White noise = flat amplitude vs frequency

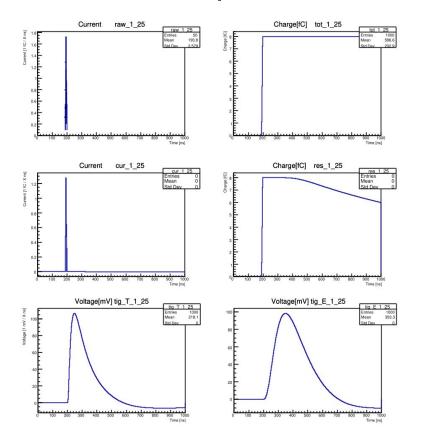
Simulation time ~ 1e7 time bin -> 10s



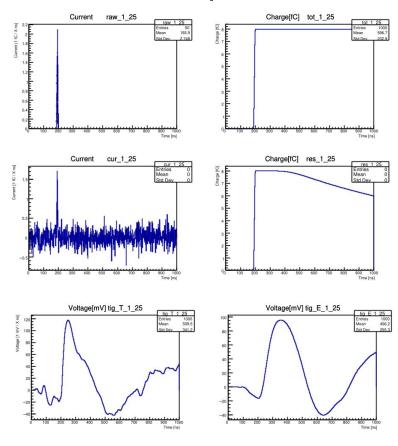
#### White noise implementation



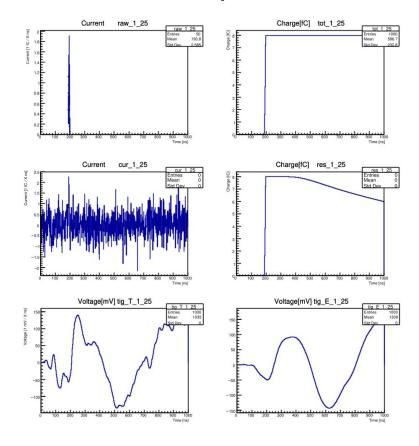
#### White noise implementation - no noise



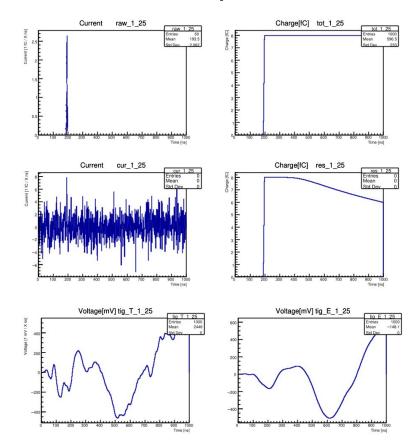
#### White noise implementation - amplitude 0.1



### White noise implementation - amplitude 0.3



### White noise implementation - amplitude 1



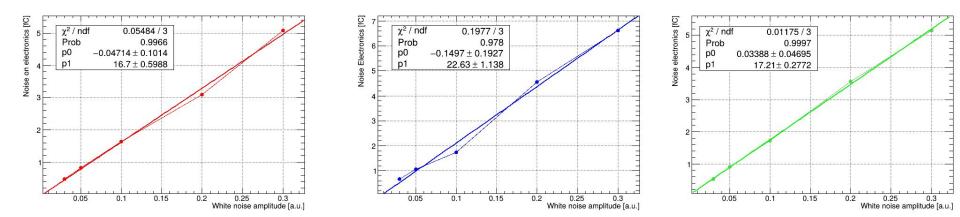
## Noise calibration in PARSIFAL



APV



TIGER



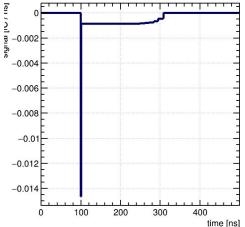
Given the same white noise amplitude, the noise collected on the E-branch of the TIGER is the larger.

In general, the longer is the shaping time, the larger is the noise amplitude.

# Single electron/ion induction

Ground model for the induction is to inject a pulse of 1ns and 1.6e-4fC once the electron reach the readout plane of the  $\mu$ RWELL.

To improve the reliability of the induction, the ion tails needs to be considered. A simulation of 1 e- and 1 Ar+ drift along +60 $\mu$ m and -60 $\mu$ m together the relative induction of a plane is reported.

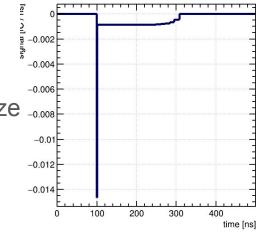


# Single electron/ion induction

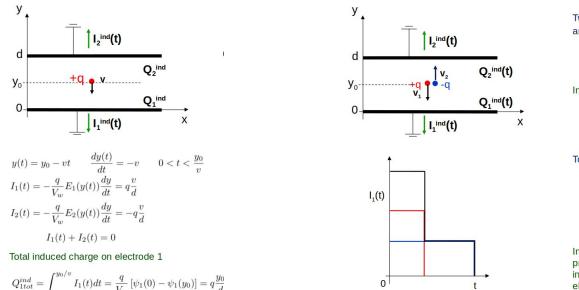
```
electron+ion peak amplitude = -0.01463 fC/ns
after 1ns the bump goes down to the ion tail
```

ion tail amplitude = -0.00085 fC/ns ion tail duration = 140ns @ fix value + 70 ns to go ze -

time bin size | ratio e+l / l 1ns | 0.058 (1 bin) 0.1ns | 0.060 (10 bin)



## The induced current depends on the ionization place



Two charges +q, -q moving from  $y_0$  to the electrodes with velocities  $v_1$  and  $v_2$ , arriving at the electrodes at times  $t_1$  and  $t_2$ 

$$t_1 = \frac{y_0}{v_1} \qquad t_2 = \frac{d - y_0}{v_2}$$

Induced currents

 $I_1(t) = q \frac{v_1}{d} \Theta(t_1 - t) + q \frac{v_2}{d} \Theta(t_2 - t) \qquad I_2(t) = -I_1(t)$  $I_2(t) = -I_1(t)$ 

Total induced charges

$$\begin{array}{lcl} Q_{1tot}^{ind} & = & \int_{0}^{\infty} I_{1}(t) dt \\ & = & \frac{q}{V_{w}} \left[ \psi_{1}(0) - \psi_{1}(y_{0}) \right] - \frac{q}{V_{w}} \left[ \psi_{1}(d) - \psi_{1}(y_{0}) \right] \\ & = & q \end{array}$$

In all physics processes, pairs of charges with opposite sign are produced at the same position, which results in the fact that the total induced charge is equal to the charge that has arrived at the electrode, once ALL charges have arrived at the electrodes.

If you wait enough time, the total charge is Q, where Q=Ne\*gain.

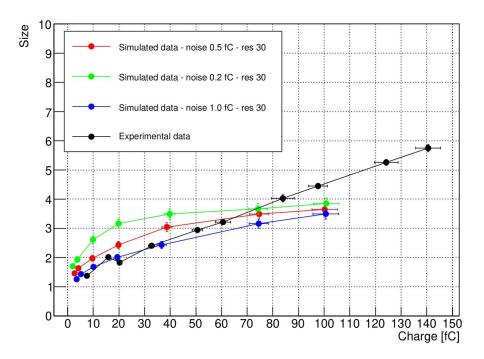
The fast (electron) and slow (ion) contribution is not 50-50. A precise number can be extracted from the weighting field evaluation. On RPC this fraction is 5:95 while on MicroMegas is 15:85.

We can assume a Micromegas-like signal induction.

#### Noise scan

Exp. data from TB 2021 and resistivity 80MOhm/square

Noise impact on the low-charge regime with an impact on the cluster size.



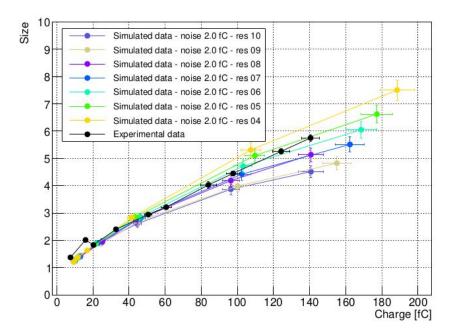
## Gain scan in exp and sim

Exp. data from TB 2021 and resistivity 80MOhm/square

Resistivity simulation a là Dixit + GF formula.

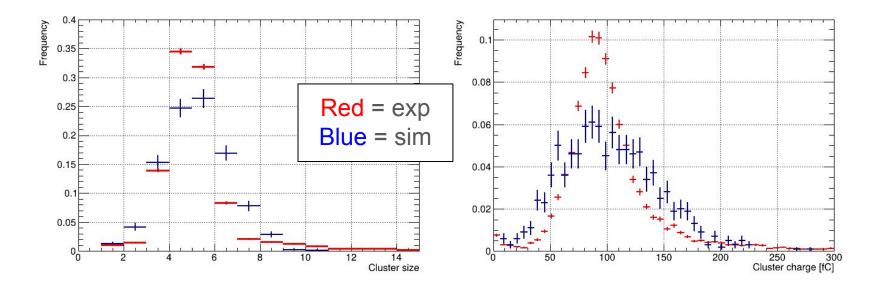
Tuning ongoing on sigma\_0 and tau parameters.

$$\begin{split} Q(t) &= \int_{x_1}^{x_2} \rho(x, t) \mathrm{d}x \\ &= \frac{q}{\sqrt{2\pi} \left[ \sigma_0 \left( 1 + \frac{t - t_0}{\tau} \right) \right]} \int_{x_1}^{x_2} \exp\left[ -\frac{(x - x_0)^2}{2\sigma_0^2 \left( 1 + \frac{t - t_0}{\tau} \right)^2} \right] \Theta\left( t - t_0 \right) \mathrm{d}x \\ &= \frac{q}{2} \left[ \exp\left( \frac{x_2 - x_0}{\sqrt{2}\sigma_0 \left( 1 + \frac{t - t_0}{\tau} \right)} \right) - \exp\left( \frac{x_1 - x_0}{\sqrt{2}\sigma_0 \left( 1 + \frac{t - t_0}{\tau} \right)} \right) \right] \Theta\left( t - t_0 \right) \end{split}$$



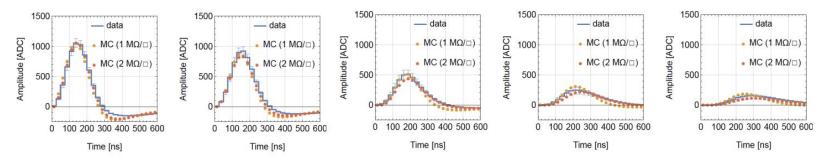
#### Gain scan in exp and sim

There is a resistivity value that matches the experimental data but looking into the details of the run, we found some discrepancies.



## Next step 1

- 1. Tune sigma\_0 parameter to match the cluster charge distribution
- 2. Check the time distribution of the single event to complete the tuning on APV



3. Use the resistivity value from APV gain scan and check the matching with TIGER gain scan

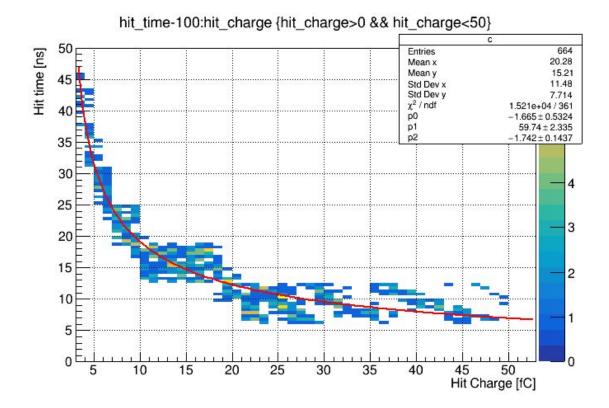
# Next step 2

- 4. Validate the gain scan for APV and TIGER and performance measurement
  - a. efficiency
  - b. resolution
- 5. Validate the resistivity scan
- 6. Validate the drift scan (to test different drift velocity)
  - a. charge collection

# Next step 3

- 7. Scan in shaping time (Tpeak) and electron drift velocity
  - a. noise
  - b. charge collected
  - c. time-walk
  - d. performance
- 8. Charge dynamic range
  - a. saturation
  - b. charge collected
  - c. performance
- 9. Cancellazione di polo zero
- 10. Multi-sampling (APV)
- 11. Misure tempo con doppia soglia
  - a. time-walk measurements
- 12. Binning diverso dai 6.25 ns

#### **µRWELL+TIGER:** timewalk studies



Simulation of a single electron ionization at fixed time and different gains.

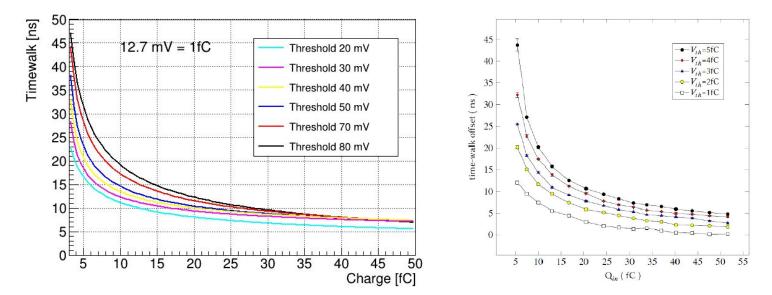
The fitting line describe the time shift due to the time-walk.

Threshold used: 80-80

#### **µRWELL+TIGER:** timewalk studies

SIM





Compatible results have been obtained.